# BFU660F

# NPN wideband silicon RF transistor

Rev. 0.8 — 23 November 2010

**Product data sheet** 

# 1. Product profile

## 1.1 General description

NPN silicon microwave transistor for high speed, low noise applications in a plastic, 4-pin dual-emitter SOT343F package.

#### **CAUTION**



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

#### 1.2 Features and benefits

- Low noise high linearity RF transistor
- High output third-order intercept point 27 dBm at 1.8 GHz
- 40 GHz f<sub>T</sub> silicon technology

### 1.3 Applications

- Analog/digital cordless applications
- X-band high output buffer amplifier
- ZigBee
- SDARS second stage LNA
- LTE, cellular, UMTS





#### 1.4 Quick reference data

Table 1. Quick reference data

tors		ORAK	> O,	OPA	BFI	<b>U6</b> 6	50F
Quick r	eference data  Quick reference data	NPN wideb	an				-
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V <sub>CBO</sub>	collector-base voltage	open emitter		-	-	16	V %
V <sub>CEO</sub>	collector-emitter voltage	open base		-	-	5.5	V
V <sub>EBO</sub>	emitter-base voltage	open collector		-	-	2.5	V
Ic	collector current			-	30	60	mΑ
P <sub>tot</sub>	total power dissipation	T <sub>sp</sub> ≤ 90 °C	[1]	-	-	225	mW
h <sub>FE</sub>	DC current gain	$I_C = 10 \text{ mA}; V_{CE} = 2 \text{ V};$ $T_j = 25 \text{ °C}$		90	135	180	
C <sub>CBS</sub>	collector-base capacitance	$V_{CB} = 2 \text{ V}; f = 1 \text{ MHz}$		-	138	-	fF
f <sub>T</sub>	transition frequency	$I_C$ = 20 mA; $V_{CE}$ = 1 V; f = 2 GHz; $T_{amb}$ = 25 °C		-	21	-	GHz
IP3 <sub>O(max)</sub>	maximum output third-order intercept point	$I_C$ = 40 mA; $V_{CE}$ = 4 V; f = 5.8 GHz; $T_{amb}$ = 25 °C		-	28	-	dBm
$G_{p(max)}$	maximum power gain	$I_C = 30 \text{ mA}; V_{CE} = 1 \text{ V};$ $f = 1.8 \text{ GHz}; T_{amb} = 25 \text{ °C}$	[2]	_	24	-	dB
NF	noise figure	$I_C$ = 6 mA; $V_{CE}$ = 2 V; f = 1.8 GHz; $\Gamma_S$ = $\Gamma_{opt}$		-	0.65	-	dB
P <sub>L(1dB)</sub>	output power at 1 dB gain compression	$I_{C}$ = 60 mA; $V_{CE}$ = 4 V; $Z_{S}$ = $Z_{L}$ = 50 $\Omega$ ; $f$ = 1.8 GHz; $T_{amb}$ = 25 °C		-	17	-	dBm

<sup>[1]</sup>  $T_{sp}$  is the temperature at the solder point of the emitter lead.

#### **Pinning information** 2.

Discrete pinning Table 2.

	Diodroto piliting		
Pin	Description	Simplified outline	Graphic symbol
1	emitter		
2	base	3 4	4
3	emitter		2
4	collector		. ,
			1, 3
		2 1	mbb159

#### **Ordering information** 3.

Table 3. **Ordering information** 

Type number	Package					
	Name	Description	Version			
BFU660F	-	plastic surface-mounted flat pack package; reverse pinning; 4 leads	SOT343F			

<sup>[2]</sup>  $G_{p(max)}$  is the maximum power gain, if K > 1. If K < 1 then  $G_{p(max)} = MSG$ .

#### **Marking** 4.

Table 4. **Marking** 

Type number	Marking	Description
BFU660F	D3*	* = p : made in Hong Kong
		* = t : made in Malaysia
		* = w : made in China

# **Limiting values**

Table 5. **Limiting values** 

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CBO}$	collector-base voltage	open emitter	-	16	V
$V_{CEO}$	collector-emitter voltage	open base	•	5.5	V
$V_{EBO}$	emitter-base voltage	open collector	-	2.5	V
I <sub>C</sub>	collector current		-	60	mA
P <sub>tot</sub>	total power dissipation	T <sub>sp</sub> ≤ 90 °C	[1] -	225	mW
T <sub>stg</sub>	storage temperature		-65	+150	°C
T <sub>j</sub>	junction temperature		-	150	°C

<sup>[1]</sup>  $T_{sp}$  is the temperature at the solder point of the emitter lead.

# Thermal characteristics

Thermal characteristics Table 6.

Symbol	Parameter	Conditions	Тур	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point		270	K/W

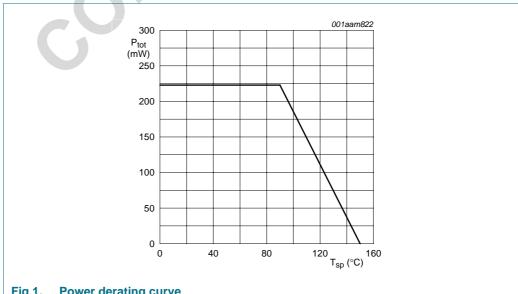


Fig 1. Power derating curve

# **Characteristics**

**Characteristics** Table 7.

	emiconductors	NPN wideba	ond eil	icon F	E tran	veieto
		NEW WIGEDS	iiiu şii	P T	op ti ai	Sisto
				7/2	, Y	
7. Ch	naracteristics				PA	PA
able 7.	Characteristics					P
	unless otherwise specified					7/
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{(BR)CBO}$	collector-base breakdown voltage	$I_C = 2.5 \mu A; I_E = 0 \text{ mA}$	16	-	-	V
$V_{(BR)CEO}$	collector-emitter breakdown voltage	$I_C = 1 \text{ mA}$ ; $I_B = 0 \text{ mA}$	5.5	-	-	V
l <sub>C</sub>	collector current		-	30	60	mΑ
I <sub>CBO</sub>	collector-base cut-off current	$I_E = 0 \text{ mA}; V_{CB} = 8 \text{ V}$	-	-	100	nΑ
h <sub>FE</sub>	DC current gain	$I_C = 10 \text{ mA}; V_{CE} = 2 \text{ V}$	90	135	180	
C <sub>CES</sub>	collector-emitter capacitance	$V_{CB} = 2 V$ ; $f = 1 MHz$	-	297	-	fF
C <sub>EBS</sub>	emitter-base capacitance	$V_{EB} = 0.5 \text{ V}; f = 1 \text{ MHz}$	-	664	-	fF
C <sub>CBS</sub>	collector-base capacitance	V <sub>CB</sub> = 2 V; f = 1 MHz	-	138	-	fF
f <sub>T</sub>	transition frequency	$I_C = 20 \text{ mA}; V_{CE} = 1 \text{ V}; f = 2 \text{ GHz};$	-	21	-	GHz
0		$T_{amb} = 25  ^{\circ}\text{C}$				
G <sub>p(max)</sub>	maximum power gain	O CE Tamb	1	25		٩D
		f = 1.5 GHz	-	25	-	dB
		f = 1.8 GHz	-	24	-	dB
		f = 2.4 GHz	-	22	-	dB
2 12	incertion power gain	f = 5.8 GHz	-	12.5	-	dB
$s_{21} ^2$	insertion power gain	$I_C = 30 \text{ mA}; V_{CE} = 1 \text{ V}; T_{amb} = 25 \text{ °C}$ f = 1.5  GHz		20		dB
		f = 1.8 GHz	-	20	-	dВ
		f = 2.4 GHz	-	18.5 16	-	dВ
		f = 5.8 GHz		8.5		dВ
NF	noise figure	$I_C = 6 \text{ mA}$ ; $V_{CE} = 2 \text{ V}$ ; $\Gamma_S = \Gamma_{opt}$ ;		0.5		uБ
VI	noise ligure	$T_{amb} = 25  ^{\circ}\text{C}$				
		f = 1.5 GHz	-	0.60	-	dB
		f = 1.8 GHz	-	0.65	-	dB
		f = 2.4 GHz	-	0.70	-	dB
		f = 5.8 GHz	-	1.20	-	dB
G <sub>ass</sub>	associated gain	$I_C$ = 6 mA; $V_{CE}$ = 2 V; $\Gamma_S$ = $\Gamma_{opt}$ ; $\Gamma_{amb}$ = 25 °C				
		f = 1.5 GHz	-	21	-	dB
		f = 1.8 GHz	-	20	-	dB
		f = 2.4 GHz	-	17.5	-	dB
		f = 5.8 GHz	-	12	-	dB
L(1dB)	output power at 1 dB gain compression	$I_{C} = 60 \text{ mA}; V_{CE} = 4 \text{ V};$ $Z_{S} = Z_{L} = 50 \Omega; T_{amb} = 25 \text{ °C}$				
		f = 1.5 GHz	-	17	-	dBm
		f = 1.8 GHz	-	17	-	dBm
		f = 2.4 GHz	-	16	-	dBm
				-		

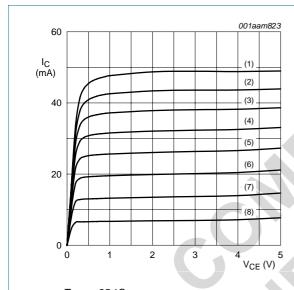


Table 7. Characteristics ...continued

 $T_i = 25 \,^{\circ}\text{C}$  unless otherwise specified

NXP Semiconductors  Table 7. Characteristicscontinued		NPN w	rideband sil	1/1	U6(	<del>-1</del>	
$\frac{I_j = 25 \text{ C}}{\text{Symbol}}$	Sunless otherwise specified  Parameter	Conditions	Min	Тур	Max	Unit	00
IP3	third-order intercept point	$I_{C}$ = 40 mA; $V_{CE}$ = 4 V; $Z_{S}$ = $Z_{L}$ = 50 $\Omega$ ; $T_{amb}$ = 25 °C				VA OR	JAN O
		f = 1.5 GHz	-	27	-	dBm	7/A
		f = 1.8 GHz	-	27	-	dBm	OPA
		f = 2.4 GHz	-	27	-	dBm	4
		f = 5.8 GHz	-	28	-	dBm	

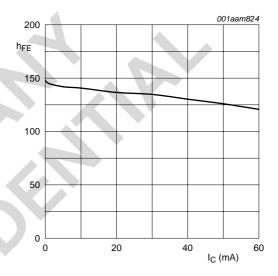
[1]  $G_{p(max)}$  is the maximum power gain, if K > 1. If K < 1 then  $G_{p(max)} = MSG$ .



 $T_{amb} = 25 \, ^{\circ}C.$ 

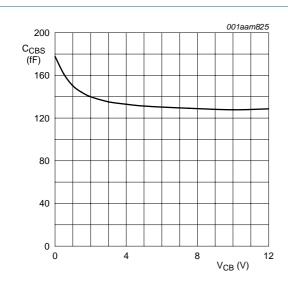
- (1)  $I_B = 400 \mu A$
- (2)  $I_B = 350 \mu A$
- (3)  $I_B = 300 \mu A$
- (4)  $I_B = 250 \mu A$
- (5)  $I_B = 200 \mu A$
- (6)  $I_B = 150 \mu A$
- (7)  $I_B = 100 \mu A$
- (8)  $I_B = 50 \mu A$

Collector current as a function of Fig 2. collector-emitter voltage; typical values



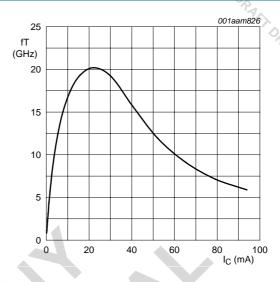
 $V_{CE}$  = 2 V;  $T_{amb}$  = 25 °C.

DC current gain as a function of collector Fig 3. current; typical values



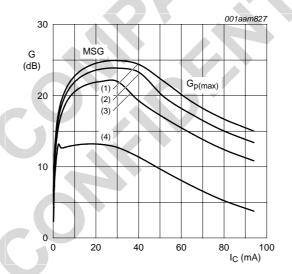
f = 1 MHz,  $T_{amb} = 25$  °C.

Fig 4. Collector-base capacitance as a function of collector-base voltage; typical values



 $V_{CE} = 1 \text{ V}$ ; f = 2 GHz;  $T_{amb} = 25 \text{ °C}$ .

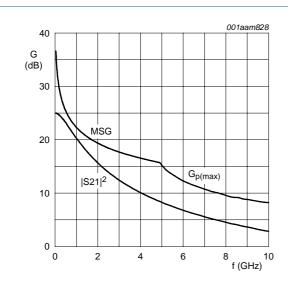
Fig 5. Transition frequency as a function of collector current; typical values



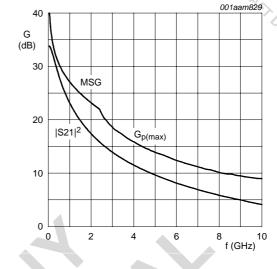
 $V_{CE} = 1 \text{ V; } T_{amb} = 25 \text{ }^{\circ}\text{C}.$ 

- (1) f = 1.5 GHz
- (2) f = 1.8 GHz
- (3) f = 2.4 GHz
- (4) f = 5.8 GHz
- (5) f = 12 GHz

Fig 6. Gain as a function of collector current; typical value



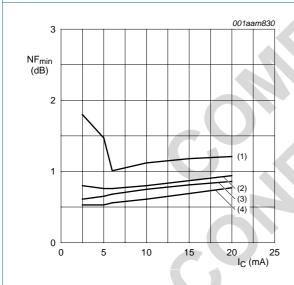
 $V_{CE}$  = 1 V;  $I_{C}$  = 5 mA;  $T_{amb}$  = 25 °C.



 $V_{CE} = 1 \text{ V; } I_{C} = 30 \text{ mA; } T_{amb} = 25 \text{ °C.}$ 

Fig 7. Gain as a function of frequency; typical values

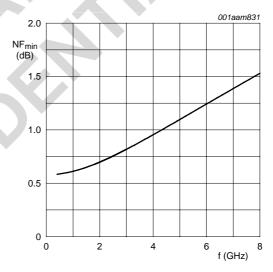




 $V_{CE} = 2 \text{ V}; T_{amb} = 25 \text{ °C}.$ 

- (1) f = 5.8 GHz
- (2) f = 2.4 GHz
- (3) f = 1.8 GHz
- (4) f = 1.5 GHz

Fig 9. Minimum noise figure as a function of collector current; typical values



 $V_{CE}$  = 2 V;  $I_{C}$  = 6 mA;  $T_{amb}$  = 25 °C.

Fig 10. Minimum noise figure as a function of frequency; typical values

# 8. Package outline

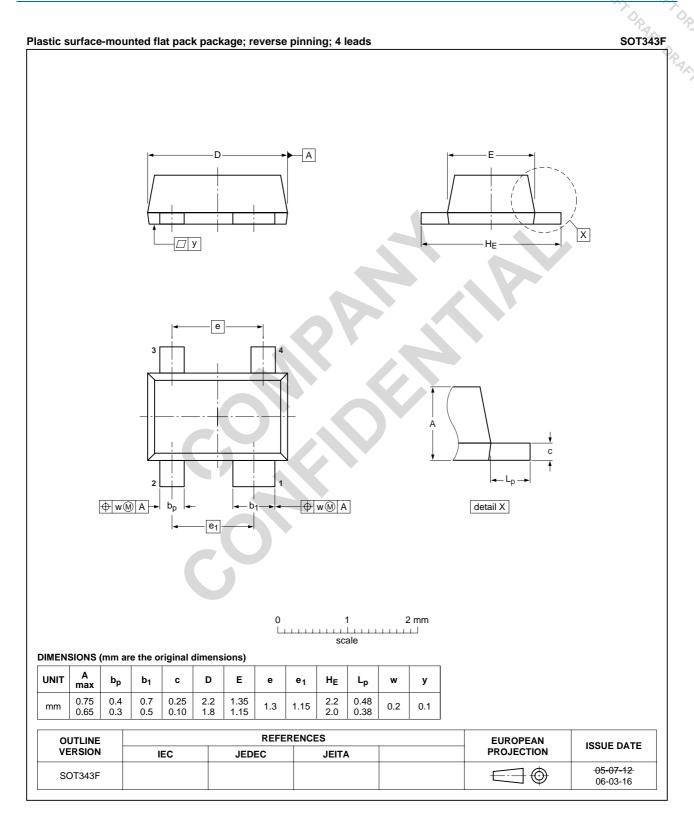


Fig 11. Package outline SOT343F



# 9. Abbreviations

Table 8. Abbreviations

	7
Acronym	Description
DBS	Direct Broadcast Satellite
DC	Direct Current
DRO	Dielectric Resonator Oscillator
Ka	Kurtz above
LNA	Low Noise Amplifier
LNB	Low Noise Block
LTE	Long Term Evolution
NPN	Negative-Positive-Negative
RF	Radio Frequency
SDARS	Satellite Digital Audio Radio Service
UMTS	Univeral Mobile Telecommunications System

# 10. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BFU660F v.1	<tbd></tbd>	Product data sheet	-	-

# 11. Legal information

#### 11.1 Data sheet status

NXP Semiconduc	tors	BFU660F
		NPN wideband silicon RF transistor
11. Legal infor	mation	DRA DRA DRA
11.1 Data sheet	status	DRALL DRALL
Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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#### NPN wideband silicon RF transistor

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For sales office addresses, please send an email to: salesaddresses@nxp.com



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